

Search Notes**Application/Control No.**

10/517,744

Examiner

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Applicant(s)/Patent under Reexamination

MAASS ET AL.

Art Unit

2612

SEARCHED

Class	Subclass	Date	Examiner
340	436	3/13/2007	JAT
	435	3/13/2007	JAT
	437	3/13/2007	JAT
	937	3/13/2007	JAT
180	280	3/13/2007	JAT
	274	3/13/2007	JAT

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

INTERFERENCE SEARCHED

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